Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/542,081	TAKAMURO ET AL.	
Examiner	Art Unit	

Bruck Kifle, Ph.D.

1624

	SEARCHED				
Class	Subclass	Date	Examiner		
544	262	8/17/2007	вк		
514	262.1	8/17/2007	ВК		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH N (INCLUDING SEARC)
	DATE	EXMR
CAS	8/17/2007	вк
Inventor name search (eDAN)	8/17/2007	вк
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